

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









AO7407 20V P-Channel MOSFET

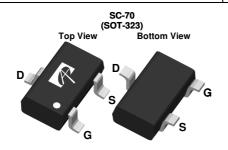
General Description

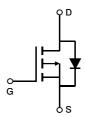
The AO7407 uses advanced trench technology to provide excellent $R_{\text{DS(ON)}}$, low gate charge and operation with gate voltages as low as 1.8V. This device is suitable for use as a load switch or in PWM applications.

Product Summary

 $\begin{array}{lll} V_{DS} & -20V \\ I_{D} \; (at \; V_{GS}{=}{-}4.5V) & -1.2A \\ R_{DS(ON)} \; (at \; V_{GS}{=}{-}4.5V) & < 135 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS}{=}{-}2.5V) & < 170 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS}{=}{-}1.8V) & < 220 m\Omega \\ \end{array}$







Absolute Maximum Ratings	T _A =25℃ unless otherwise noted
--------------------------	--

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	-20	V
Gate-Source Voltage		V_{GS}	±8	V
Continuous Drain	T _A =25℃	1	-1.2	
Current	T _A =70℃	'D	-1	Α
Pulsed Drain Current C		I _{DM}	-10	
	T _A =25℃	P _D	0.63	W
Power Dissipation ^B	T _A =70℃		0.4	VV
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C

Thermal Characteristics					
Parameter		Symbol	Тур	Max	Units
Maximum Junction-to-Ambient A	t ≤ 10s	D	160	200	C/W
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	180	220	
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	130	160	℃/W



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC PARAMETERS							
BV _{DSS}	Drain-Source Breakdown Voltage	I_D =-250 μ A, V_{GS} =0V	-20			V	
I _{DSS} Zero Gate Voltage Drain Current	V _{DS} =-20V, V _{GS} =0V			-1			
I _{DSS}	Zero date voltage Brain Guirent	T _J =55℃			-5	μΑ	
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±8V			±100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=-250\mu A$	-0.4	-0.65	-1	V	
I _{D(ON)}	On state drain current	V_{GS} =-4.5V, V_{DS} =-5V	-10			Α	
R _{DS(ON)} Static Drain-Source On-Resistance	V _{GS} =-4.5V, I _D =-1.2A		65	135	m()		
	Statia Drain Source On Posistance	T _J =125℃		90	175	mΩ	
	V_{GS} =-2.5V, I_D =-1A		80	170	mΩ		
		V _{GS} =-1.8V, I _D =-1A		100	220	mΩ	
g _{FS}	Forward Transconductance	V_{DS} =-5V, I_D =-1.2A		10		S	
V_{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V		-0.7	-1	V	
Is	Maximum Body-Diode Continuous Current				-1	Α	
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance			560	745	pF	
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =-10V, f=1MHz		80		pF	
C_{rss}	Reverse Transfer Capacitance			70		pF	
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		15	23.0	Ω	
SWITCHI	NG PARAMETERS						
Q_g	Total Gate Charge			8.5	11	nC	
Q_{gs}	Gate Source Charge	V_{GS} =-4.5V, V_{DS} =-10V, I_{D} =-1.2A		1.2		nC	
Q_{gd}	Gate Drain Charge	1		2.1		nC	
t _{D(on)}	Turn-On DelayTime			7.2		ns	
t _r	Turn-On Rise Time	V_{GS} =-4.5V, V_{DS} =-10V, R_L =8.3 Ω ,		36		ns	
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		53		ns	
t _f	Turn-Off Fall Time]		56		ns	
t _{rr}	Body Diode Reverse Recovery Time	I _F =-1.2A, dI/dt=100A/μs		37	49	ns	
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =-1.2A, dI/dt=100A/μs		27		nC	

A. The value of R_{BJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leq 10s junction-to-ambient thermal resistance.

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT_J=25° C.

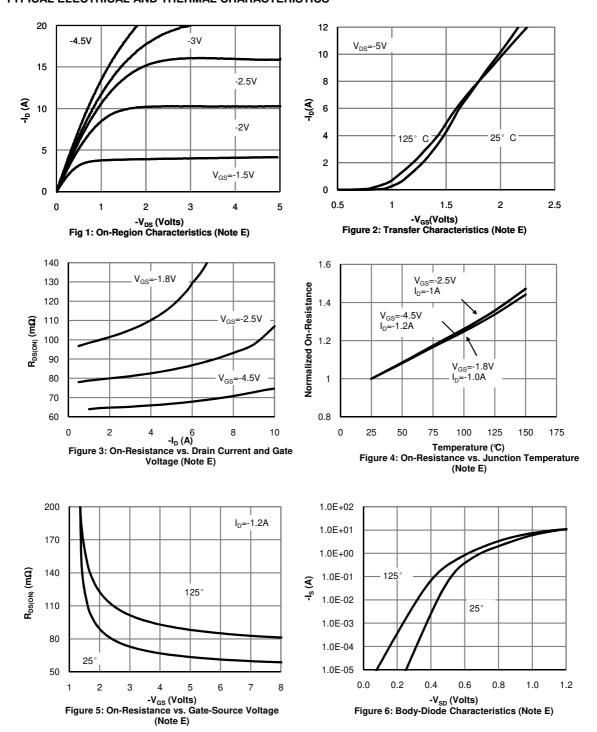
D. The R_{0,JA} is the sum of the thermal impedence from junction to lead R_{0,JL} and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

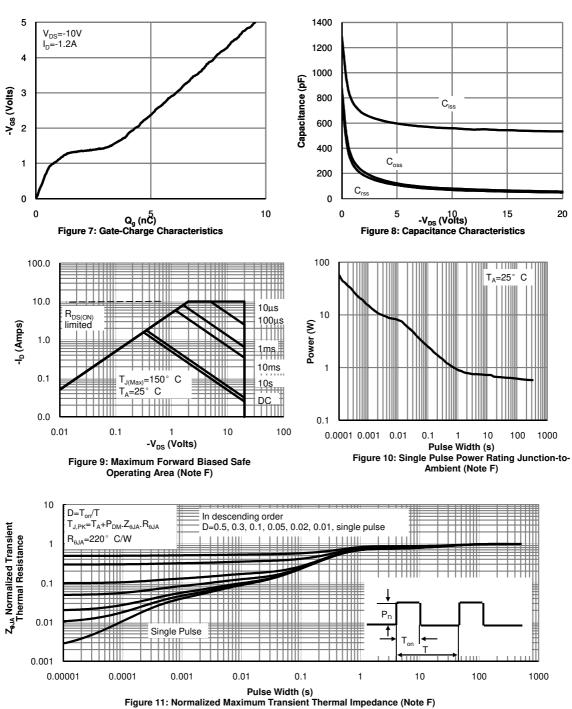


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



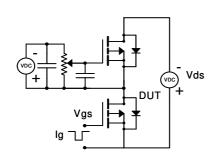


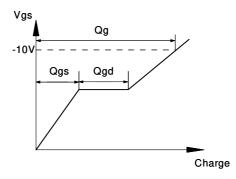
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



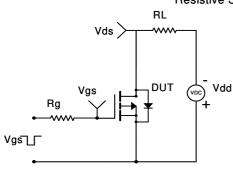


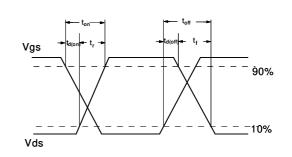
Gate Charge Test Circuit & Waveform



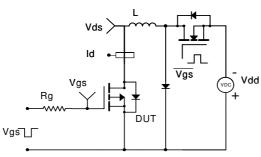


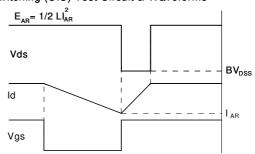
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

